

Issue Date: 3/9/2020

Rev. \*A

# Cypress Semiconductor Reliability Qualification Report

QTP# 190301, 192004 Version \*A

## CYW20719B2 / CYW20721B2

CYW20719B2 / CYW20721B2, Enhanced Low Power, Bluetooth 5.0/BLE/2 Mbps LE/EDR/Integrated SOC

# FOR ANY QUESTIONS ON THIS REPORT, PLEASE CONTACT reliability@cypress.com or via a CYLINK CRM CASE

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#### I.A. Product and Package Information

Product Description: CYW20719B2KWB9GT Cypress Division: IoT Division

Enhanced Low Power, Bluetooth 5.0/BLE/2 Mbps LE/EDR/Integrated SOC

Package: WLCSP QTP: 190301

Description: (3.31 x 3.22 x 0.33mm) 134 Ball, Wafer Level Chip Scale Package (WLCSP) Flammability: O2 Index:

Assembly: ASE Taiwan Molding Compound: N/A UL-V0 >28

Electrical Test: ASE Taiwan

Substrate/Leadframe: N/A Die Attachment: N/A

Lead Finish: 98.2Sn / 1.8Ag

**Comments:** 

Est. Field Temperature: 55 °C Life Test Temperature: 125 °C

Est. DC Field Current: 20 mA Life Test Dynamic Current: 20 mA

**Est. Field Voltage:** 1.2  $\,\mathrm{V}$  **Life Test Voltage:** 1.38  $\,\mathrm{V}$ 

Est. Field Power Dissipation: 24 mWatts Est. Stress Power Dissipation: 27.6 mWatts

**Die:** 20719YPB2DA **Die Size:** 3.35 x 3.26 mm

Process:40NM LPFab:TSMCType:BluetoothDensity:N/A



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#### I.B. Product and Package Information

Product Description: CYW20721B2KUMLG Cypress Division: IoT Division

Enhanced Low Power, Bluetooth 5.0/BLE/2 Mbps LE/EDR/Integrated SOC

Package: QFN QTP: 190301a

**Description:** (5 x 5 x 0.6mm) 40 Pin, Quad Flat No Lead Package (QFN) **Flammability: 02 Index:** 

Assembly: SPIL-TAIWAN Molding Compound: HITACHI\_CEL-9240-HF UL-V0 >28

Electrical Test: ASE Singapore

Substrate/Leadframe: Copper Leadframe Die Attachment: Hitachi EN-4900GC

Lead Finish: 100% Matte Sn Plating

**Comments:** 

Est. Field Temperature: 55 °C Life Test Temperature: 125 °C
Est. DC Field Current: 20 mA Life Test Dynamic Current: 20 mA
Est. Field Voltage: 1.2 V Life Test Voltage: 1.38 V

Est. Field Power Dissipation: 24 mWatts Est. Stress Power Dissipation: 27.6 mWatts

**Die:** 20721PB2DA **Die Size:** 3.35 x 3.26 mm

 Process:
 40NM LP
 Fab:
 TSMC

 Type:
 QFN
 Density:
 N/A



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#### I.C. Product and Package Information

Product Description: CYW20721B2KWB9GT Cypress Division: IoT Division

Enhanced Low Power, Bluetooth 5.0/BLE/2 Mbps LE/EDR/Integrated SOC

Package: WLCSP QTP: 190301b

Description: (3.31 x 3.22 x 0.33mm) 134 Ball, Wafer Level Chip Scale Package (WLCSP) Flammability: O2 Index:

Assembly: ASE Taiwan Molding Compound: N/A UL-V0 >28

Electrical Test: ASE Taiwan

Substrate/Leadframe: N/A Die Attachment: N/A

Lead Finish: 98.2Sn / 1.8Ag

**Comments:** 

Est. Field Temperature: 55 °C Life Test Temperature: 125 °C

Est. DC Field Current: 20 mA Life Test Dynamic Current: 20 mA

Est. Field Voltage: 1.2 V Life Test Voltage: 1.38 V

Est. Field Power Dissipation: 24 mWatts Est. Stress Power Dissipation: 27.6 mWatts

**Die:** 20721YPB2DA **Die Size:** 3.35 x 3.26 mm

Process:40NM LPFab:TSMCType:BluetoothDensity:N/A



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#### I.D. Product and Package Information

Product Description: CYW20719B2KUMLG Cypress Division: IoT Division

Enhanced Low Power, Bluetooth 5.0/BLE/2 Mbps LE/EDR/Integrated SOC

Package: QFN QTP: 190301c

**Description:** (5 x 5 x 0.6mm) 40 Pin, Quad Flat No Lead Package (QFN) Flammability: **O2 Index:** 

Assembly: SPIL-TAIWAN Molding Compound: HITACHI\_CEL-9240-HF UL-V0 >28

Electrical Test: ASE Singapore

Substrate/Leadframe: Copper Leadframe Die Attachment: Hitachi EN-4900GC

Lead Finish: 100% Matte Sn Plating

**Comments:** 

Est. Field Temperature: 55 °C Life Test Temperature: 125 °C

Est. DC Field Current: 20 mA Life Test Dynamic Current: 20 mA

Est. Field Voltage: 1.2 V Life Test Voltage: 1.38 V

Est. Field Power Dissipation: 24 mWatts Est. Stress Power Dissipation: 27.6 mWatts

**Die:** 20719B2DA **Die Size:** 3.35 x 3.26 mm

 Process:
 40NM LP
 Fab:
 TSMC

 Type:
 QFN
 Density:
 N/A



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#### I.E. Product and Package Information

Product Description: CYW20721B2KUMLG Cypress Division: IoT Division

Enhanced Low Power, Bluetooth 5.0/BLE/2 Mbps LE/EDR/Integrated SOC

Package: QFN QTP: 192004

**Description:** (5 x 5 x 0.6mm) 40 Lead, Quad Flat No Lead Package (QFN) Flammability: **O2 Index:** 

Assembly: ASE Taiwan Molding Compound: Sumitomo EME G700LA UL-V0 >28

Electrical Test: ASE Taiwan

Substrate/Leadframe: Copper Leadframe Die Attachment: Hitachi EN-4900F

Lead Finish: 100% Matte Sn Plating

**Comments:** 

Est. Field Temperature: 55 °C Life Test Temperature: 125 °C
Est. DC Field Current: 20 mA Life Test Dynamic Current: 20 mA
Est. Field Voltage: 1.2 V Life Test Voltage: 1.38 V

Est. Field Power Dissipation: 24 mWatts Est. Stress Power Dissipation: 27.6 mWatts

**Die:** 20721PB2DA **Die Size:** 3.35 x 3.26 mm

 Process:
 40NM LP
 Fab:
 TSMC

 Type:
 QFN
 Density:
 N/A



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### II. 40nm GLL/LP/RF Life Test Failure Rate Calculation

#### HTOL Stress Temperature - 125 °C

	Read Points / Test Results				Мо	Modeling Parameters @ 55°C					Avg. Failure Rate FITS @55°C, 60% Conf.		
Failure Mechanism	24 hrs	168 hrs	500 hrs	1000 hrs	Ea eV	TAF	VAF	OAF	MTTF (yrs)	PPM	FIT		
PLASTIC													
Sample Size	2716	2519	1559	1559									
Zero fails, Process ave. Ea	0 *	0	0	0	0.66	71	1	71					
Totals	0	0	0	0					14269	0	8		

<sup>\* -</sup> Contributes to early life FITS



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# **III. Summary of Stress Test Results**

Stress Test	Stress Condition	Package Type	Sample Size	Num. of l	Num. of Fails	Failure Rate %	Comments		
Data From Qualification 190301, 190301a, 192004:									
High Temp Bake	(175°C)	QFN <sup>3</sup>	45	1	0	0.00	500 Hours		
ESD CDM	N/A	WLCSP 1	3	1	0	0.00	Passed 500V		
	N/A N/A	QFN <sup>2</sup> QFN <sup>3</sup>	3 3	1 1	0	0.00	Passed 500V Passed 1.0kV		
ESD HBM	N/A	WLCSP 1	3	1	0	0.00	Passed 2.0kV		
	N/A	QFN <sup>2</sup>	3	1	0	0.00	Passed 2.0kV		
Latch Up	(125°C, +/- 200mA)	WLCSP 1	3	1	0	0.00	Passed		
	(125°C, +/- 200mA)	QFN <sup>2</sup>	3	1	0	0.00	Passed		
Preconditioning	(PC2/260°C, +0°C/-5°C)	QFN <sup>3</sup>	383	3	Passe	d			
Precon+Temp Cycle	(PC2/260°C, -65°C/150°C)	QFN <sup>3</sup>	231	3	0	0.00	500 Cycles		
Precon+HAST	(PC2/260°C, Biased, 130°C/85% RH)	QFN <sup>3</sup>	75	3	0	0.00	96 Hours		
Precon+uHAST	Precon+uHAST (PC2/260°C, Unbiased, 130°C/85% RH)		77	1	0	0.00	96 hours		
Solderability	N/A	QFN <sup>3</sup>	9	1	Passe	d			

Notes / Justification: 1) Results from Qual 190301, CYW20719B2KWB9GT, 40NM LP Bluetooth in 134 Ball WLCSP (3.31 x 3.22 x 0.33mm)

2) Results from Qual 190301a, CYW20721B2KUMLG, 40NM LP QFN in 40 Pin QFN (5 x 5 x 0.6mm)

3) Results from Qual 192004, CYW20721B2KUMLG, 40NM LP QFN in 40 Lead QFN (5 x 5 x 0.6mm)

Preconditioning Flows: PC2 (JEDEC L3): Bake 125°C, 24hr => Soak @ 30°C/60%RH, 192hr => 3x Reflow

#### **Reliability Tests Performed per Specification Requirements**

Stress	Condition	Specification Reference		
ESD CDM	N/A	JS002 / AEC-Q100-011		
ESD HBM	N/A	JS001 / AEC-Q100-002		
High Temp Bake	(175°C)	JESD22-A103		
Latch Up	(125°C, +/- 200mA)	JESD78 / AEC Q100-004		
Precon+HAST	(PC2/260°C, Biased, 130°C/85% RH)	JESD22-A110		
Precon+Temp Cycle	(PC2/260°C, -65°C/150°C)	JESD22-A104		
Precon+uHAST	(PC2/260°C, Unbiased, 130°C/85% RH)	JESD22-A118		
Preconditioning	(PC2/260°C, +0°C/-5°C)	J-STD-020		
Solderability	N/A	J-STD-002		



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#### IV. Revision History

**Document Number:** 002-28997

**Document Title:** CYW20719B2 / CYW20721B2, Enhanced Low Power, Bluetooth 5.0/BLE/2 Mbps

LE/EDR/Integrated SOC

Rev.	Issue Date	ECN#	Originator	Description
**	11/18/2019	6733035	BAKC	Initial Release.
*A	3/9/2020	6825712	BAKC	Added QFN Package Data

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